Colloidal quantum dot solar cell electrical parameter non-destructive quantitative imaging using high-frequency heterodyne lock-in carrierography and photocarrier radiometry

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A R T I C L E   I N F O

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A B S T R A C T

Colloidal quantum dot (CQD) solar cells with a certified power conversion efficiency of 11.28% were characterized using camera-based heterodyne lock-in carrierography (HeLIC) and photocarrier radiometry (PCR). Carrier lifetime, diffusivity, and diffusion and drift length of a CQD solar cell were imaged in order to investigate carrier transport dynamics, as well as solar cell homogeneity and the effects of Au contacts on carrier transport dynamics. Using room temperature HeLIC imaging which has also been demonstrated using PCR measurements, shorter carrier lifetimes (ca. 0.5 μs) were found in Au contact regions that can be attributed to enhanced non-radiative recombinations through trap states at Au/CQD interfaces. This imaging methodology shows strong potential for elucidating the energy loss physics of CQD solar cells and for industrial non-destructive large-area photovoltaic device characterization.

1. Introduction

Colloidal quantum dots (CQDs) with tunable bandgap through effective control over CQD sizes have become promising candidates for fabricating low-cost, large-area, flexible, and lightweight solar cells [1–6]. Although CQD solar cell efficiencies have been boosted to 13.4% [7], there is still space for further improvement for commercial applications. Therefore, understanding of CQD solar cell energy loss mechanisms through factors such as film/contact interfaces [2,8], inefficient electrode collection of carriers [2,6], various trap states [9–12], CQD size polydispersity [13–15], and CQD bandtail states which deteriorate open-circuit voltage and inhibit carrier transport [1,6], is necessary for future photovoltaic device optimization.

Nowadays, large-area photovoltaic solar cells prevail, the characterization of which fulfills various purposes including shading effects, fundamental carrier transport dynamics, mechanical and electrical defect evaluation. Therefore, large-area characterization methodologies are needed for CQD solar cell efficiency optimization. Spatially resolved photoluminescence (PL) and electroluminescence (EL) constitute powerful methodologies for the characterization of silicon wafers [16–18] and solar cells [18–21]. They yield measurements of minority carrier hopping lifetime [16,17,20], open-circuit voltage [18,20,21], current density [21], series resistance [21], fill factor [18,21], and quality monitoring in different device fabrication steps [19]. Furthermore, due to the high signal-to-noise ratio (SNR), synchronous frequency-domain imaging methodologies are emerging, such as the lock-in thermography (LIT) [22] that has been used for determining series resistance and recombination current at a frequency of 20 Hz. However, static (dc) PL and EL, and low-frequency LIT limited by the low camera frame rate, cannot monitor electronic transport kinetics and recombination dynamics. The latter, however, are key parameters for the determination of photovoltaic energy conversion and dissipation.

To address these critical issues, here we introduce single detector-based photocarrier radiometry (PCR), and camera-based homodyne (HoLIC) and heterodyne (HeLIC) lock-in carrierographies for the characterization CQD solar cells. HoLIC imaging and PCR are the same type of dynamic spectrally gated frequency-domain photoluminescence modality and can yield quantitative information about carrier transport dynamics with accuracy and precision superior to the time-resolved PL due to their intrinsically high signal-to-noise ratio (SNR) by virtue of...
lock-in demodulation [23,24]. HoLIC has advantages as an all-optical non-destructive imaging technique for large-area photovoltaic device imaging, yet it is limited to the low modulation frequency range (< 1 kHz) due to the low frame rates of conventional cameras [25]. Using a single InGaAs detector, PCR can attain high-frequency characterization (> 100 kHz), however, the fast large-area imaging capability is compromised. Through creating a slow enough beat frequency component, HeLIC overcomes the high-frequency limitation of conventional camera-based optical characterization techniques and the poor SNR at short exposure times associated with high frame rates [26] to realize frequency-modulated imaging at more than 100 kHz. Therefore, with higher SNR than dc PL imaging, HeLIC can attain a wide range of frequency-dependent ac carrier diffusion lengths to generate depth-selective/resolved high-frequency imaging of carrier transport parameters in large-scale devices. It should be noted that all three techniques (PCR, HoLIC, and HeLIC) have no low-frequency limitations.

Therefore, to study carrier transport dynamics in CQD solar cells and the effects of CQD layer inhomogeneity (for example, induced at various fabrication stages) and contact/interface effects on solar cell performance, we combined a J-V model with PCR and HeLIC to quantitatively produce carrier lifetime, diffusivity, and drift and diffusion length images for a high-efficiency CQD solar cell under frequency-modulated excitation. This methodology has a strong potential impact on solar cell efficiency optimization and on industrial non-destructive solar cell quality control.

2. Theoretical methods

2.1. Solar cell under harmonic excitation

The nature of photocarrier generation, discrete hopping transport, and recombination in CQD-based thin films was found to follow a hopping diffusion transport behavior [2,27] under frequency-modulated laser excitation that reveals details of carrier hopping transport dynamics in these photovoltaic materials. Here, in order to extract charge carrier hopping transport dynamics in CQD-based solar cells Fig. 1(a), light-matter interaction under modulated-frequency excitation is investigated as an extension of conventional current-voltage characterization of CQD solar cells under dc laser excitation [2,6,28]. Reviewing the CQD solar cell structure in Fig. 1, due to the larger bandgap energy of ZnO than the incident photon excitation energy and the thicker CQD layers than ZnO, charge carriers and excitons are considered to be generated only in CQD layers, thus contributing to the primary current within this type of solar cell. In a manner similar to the carrier hopping transport model under static excitation [2], as electrons are injected from CQD layer to the electron-accepting ZnO nanoparticles [1], the rate equation for electrons in the CQD layers under dynamic illumination can be written as

$$\frac{\partial n(x,t)}{\partial t} = \frac{\partial J_{ee}(x,t)}{\partial x} - \frac{\Delta n(x,t)}{\tau} + g(x,t)$$

(1)

$$\Delta n(x,t)$$ is the excess electron density and $$J_{ee}(x,t)$$ is the electron current flux; $$\tau$$ is the electron lifetime, and $$g(x,t)$$ is the carrier generation rate. Considering that the ambipolar diffusion coefficient and mobility, $$J_{ee}(x,t)$$ can be further defined by [29,30]

$$J_{ee}(x,t) = D_e \frac{\partial \Delta n(x,t)}{\partial x} + \mu_e E \Delta n(x,t)$$

(2)

where $$D_e$$ is the diffusivity, $$\mu_e$$ is the mobility, and $$E$$ is the electric field (a constant value given between the external and intrinsic electric fields), Eq. (1) is reduced to a diffusion equation which can be solved using the Green function method and transferred to the frequency domain through a Fourier transformation [29]. Upon harmonic optical excitation, the photoexcited excess carrier distribution follows the Beer-Lambert Law:

$$g(x, \omega) = \frac{\beta \Delta \rho}{2h\nu} e^{-\beta x}(1+e^{i\omega t})$$

(3)

where $$\beta$$ is the optical absorption coefficient, $$\eta$$ is the quantum yield of the photogenerated carriers, and $$h$$ and $$\nu$$ are the Plank constant and the frequency of incident photons, respectively. $$I_0$$ denotes the incident photon intensity. In the one-dimensional geometry, the boundary conditions at $$x=0$$ and $$d$$, Fig. 1(b), can be written as functions of surface recombination velocities ($$S_1$$ and $$S_2$$ at $$x=0$$ and $$x=d$$, respectively) and the excess carrier density at the corresponding boundaries:

$$D_e \frac{\partial \Delta N(x, \omega)}{\partial x}_{t=0} = S_1 \Delta N(0,\omega)$$

(4a)

$$-D_e \frac{\partial \Delta N(x, \omega)}{\partial x}_{t=d} = S_2 \Delta N(d,\omega)$$

(4b)

where $$\Delta N(x, \omega)$$ is the Fourier transform $$\Delta n(x, t)$$, a carrier-densitywave (CDW). Therefore, the final expression of harmonic excess carriers $$\Delta N(x, \omega)$$ can be obtained as follows

$$\Delta N(x, \omega) = \frac{\eta I_0 \beta}{4h\nu D_e} (1-R_{a2}) \{e^{-2(K_{d2}+\gamma_2)x} - (K_{a2}+\gamma_2)^2 e^{-2(K_{a2}+\gamma_2)x} \}

- R_{a1}(1-R_{a2}) \{e^{(K_{a1}+\gamma_1)x} - (K_{a1}+\gamma_1)^2 e^{(K_{a1}+\gamma_1)x} \}

+ (R_{a1}(1-R_{a2}) - R_{a1}(1-R_{a2})) e^{-(K_{a1}+\gamma_1)x} e^{-K_{a1}t} x

+ R_{a2}(1-R_{a1}) \{e^{-(K_{a2}+\gamma_2)x} - (K_{a2}+\gamma_2)^2 e^{-(K_{a2}+\gamma_2)x} \}

- 2(1-R_{a1}R_{a2}) e^{2(K_{a2}+\gamma_2)x} e^{-\beta x}$$

(5)

with the following definitions,

$$\bar{Q}_0 = \frac{\mu_e E}{2D_e \eta [\text{cm}^{-1}]}; \gamma_j = \frac{1+i\omega \tau}{D_e \tau \eta \text{[cm}^{-1}]}$$

(6a)

$$R_{ij} = \frac{D_j \sqrt{Q_j^0 + \gamma_j^2} - S_j}{D_j \sqrt{Q_j^0 + \gamma_j^2 + S_j}}$$

(6b)
\[ K_y = \sqrt{Q_y^2 + \sigma_y^2} - Q_y [\text{cm}^{-1}]; \rho_y = \frac{\beta}{K_y} \]

(6c)

As shown in Fig. 1(b), the electric field \( \vec{E} = \vec{E}_i + \vec{E}_{cd} \) (\( E_i > E_{cd} \)) prevents the spreading of the excess CDW density towards the \( x = d \) terminal of the solar cell. On the contrary, when the net electric field switches its direction it facilitates the spreading of the CDW concentration gradient, resulting in reduced energy barriers. Here, all discussion will be based on the condition that \( \vec{E} \) prevents the spreading of the excess electron CDW density, i.e. \( \vec{E} \) and \( \vec{E}_i \) have the same direction, which is a general working condition for traditional solar cells.

2.2. Homodyne and heterodyne lock-in carrierographies

The InGaAs camera based HoLIC and HeLIC methods collect photons from radiative recombination of charge CDWs or excitons in QCD photovoltaic materials and devices. The recombinational rate \( (R_0) \) is proportional to the product of the concentration of electrons \( n \) and holes \( p \) in the form of \( R_0 = knp \) [31], where \( k \) is a material-dependent constant which can be obtained from the semiconductor’s absorption coefficient. Using the CDW \( \Delta N(x, \omega) \) in the frequency domain, the homodyne and heterodyne signals can be modeled through a depth integral of the radiatively recombining free photocarrier densities:

\[ S(\omega) = \int_0^d dx \int_0^{\omega_i} \Delta N(x, \omega) \Delta P(x, \omega) + N_i |F(\lambda)| dx \]

(7)

where \( \Delta P(x, \omega) \) is the extra electronic CDW and equals \( \Delta N(x, \omega) \) according to the quasi-neutrality approximation, i.e. the photogenerated excess electron and hole concentrations are identical across the thin film thickness. \( F(\lambda) \) is an instrumental coefficient that depends on the spectral detection bandwidth \( (\omega_i, \omega_f) \) of the near-infrared detector. \( N_i \) is the equilibrium majority carrier concentration determined by material doping resulting from in-air oxidation of our QCD thin films and solar cells. PCR and HoLIC detect at only the fundamental reference frequency term. In comparison, in HeLIC the incident laser excitation is modulated at two different angular frequencies \( \omega_i \) and \( \omega_f \). Furthermore, HeLIC is tuned to the reference beat frequency \( \Delta \omega \) and its radiative recombination modulation at other frequencies will be filtered out. The demodulated signal for PCR and HoLIC can be derived using

\[ \Delta N(x, \omega) = \Delta N_0(x) + Y(x, \omega) \exp(i[\omega t + \phi(x, \omega)]) \]

(8)

in which \( Y(x, \omega) \) and \( \phi(x, \omega) \) are the amplitude and phase of the frequency-modulated CDW, respectively, and \( \Delta N_0(x) \) is the corresponding dc component. The final signal expression for PCR and HoLIC is

\[ S_{n(\omega)} = \int_0^d (2\Delta n_0(x) + N_i) \Delta N(x, \omega) dx \]

(9)

Similarly, the demodulated signal for HeLIC can be derived through

\[ \Delta N(x, \omega) = 2\Delta n_0(x) + Y(x, \omega) \exp(i[\omega t + \phi(x, \omega)]) \]

+ \( Y(x, \omega) \exp(i[\omega t + \phi(x, \omega)]) \)

(10)

Therefore, the expression for the HeLIC signal becomes

\[ S_{n(\omega)} = \int_0^d \Delta N^*(x, \omega_i) \Delta N(x, \omega) dx \]

(11)

where * denotes complex conjugation and \( \Delta n_0(x) \) is the dc component of the photogenerated excess electron CDW \( \Delta N(x, \omega) \). It should be noted that the HeLIC phase is very small (on the order of 0.001°) due to the small frequency difference \( \Delta \omega \).

Ultimately, under low injection levels, i.e. \( 2\Delta n_0(x) \ll N_i \), upon substitution of Eq. (5) into Eq. (9), the final expression of Eq. (9) after the necessary mathematical manipulations becomes

\[ S_{n(\omega)} \approx A_n \left[B(1-e^{-Kx}) + C(e^{-Kx} - e^{-2Kx}) + D(e^{-Kx} - 1) \right] \frac{\eta L_D}{\sqrt{I_{\text{ext}}}} \]

(12)

Coefficients \( A, B, C, \) and \( D \) are defined according to Eq. (5), as follows,
rather than a single detector. The NIR InGaAs camera (Goodrich SU320 KTSW-1.7RT/RS170) has 320 × 256 pixel active elements with a bandwidth of 0.9 – 1.7 µm, 120 fps frame rate, and exposure times between 0.13 and 16.6 ms. The number of camera pixels determines the spatial resolution of both HoLIC and HeLIC imaging techniques. The two diode lasers with the same excitation power deliver a combined mean laser excitation intensity of 1 sun. An optical long-pass filter is also mounted in front of the InGaAs camera to block the excitation laser beam. In order to obtain homogeneous excitation, two optical diffusers are used to minimize the intensity variation across the beam (< 5%). When the two lasers are modulated at the same frequency and in phase, HoLIC imaging is obtained (amplitude and phase images), whereas with slightly different modulation frequencies HeLIC imaging ensues at the beat frequency (amplitude images only). The data acquisition card (NI USB-6259) in Fig. 2(b) is used to generate a reference signal and external trigger to the camera in an undersampling model [25]. The frame grabber (NI PCI-1427) is applied to scan images, sixteen of which are captured in one period. For temperature control, a Linkam LST 350 cryogenic stage is used that allows maintaining constant temperature in the range between 77 K and 520 K.

4. Results and discussion

Fig. 3(a) is a photograph of the as-synthesized multilayer CQD solar cell sample (structure shown in Fig. 1) with metallic Au contacts on the top. The bottom Au contact so labeled in Fig. 3(a) is connected to an indium tin oxide (ITO) conducting layer. Each golden circle-rectangle-shaped region, for example the one circumscribed in a dashed rectangle, represents a complete solar cell structure with top Au contact, while other regions with brown color are without top contact Au deposition. The highest power conversion efficiency (PCE) of this type of solar cell has been certified to be as high as 11.28% [1], while device performances vary from sample to sample due to factors such as electrical and mechanical defects introduced during various device fabrication processes, as well as film-inhomogeneity-associated short-circuit effects. As shown in Fig. 3(b), a HoLIC image of the corresponding solar cell sample in Fig. 3(a) reveals the charge carrier distribution within an entire solar device, thereby elucidating the influence of the Au electrode on charge carrier transport, and depicting the CQD solar cell inhomogeneity that originates from various defects. Regarding imaging, the CQD solar cell sample was flipped in a mirror reflection configuration to the photograph in Fig. 3(a). With the application of Au contacts in our CQD solar cells, an aluminum thin plate (with a smooth surface that can reflect light) was placed under the CQD solar cell to experimentally eliminate the potential Au-related reflection induced effects on HoLIC and HeLIC images. The HoLIC image in Fig. 3(b) demonstrates the negligible effect of Au-related reflection through the observation that even though identical Au electrodes are seen in Fig. 3(a), several Au-reflection regions exhibit HoLIC amplitudes that are almost the same as their surroundings without deposited Au electrodes. The solar cell contact electrode circumscribed within the dashed rectangle in Fig. 3(a) and (b) has a PCE of ca. 9%, Fig. 4, and has been further investigated using HeLIC and PCR. As shown in Fig. 4, both forward and reverse current –voltage scans are presented that show very little current-voltage hysteresis of our CQD solar cells.

Fig. 5 shows four electron transport parameter images reconstructed from Eq. (14) through computational best-fitting of 27 HeLIC amplitude images taken under excitation frequencies ranging from 100 Hz to...
The distributions of electron lifetime $\tau$, diffusivity $D_0$, and diffusion $L_{\text{diff}}$ and drift $L_{\text{drif}}$ lengths have been imaged for the solar cell electrode as circumscribed with a dashed rectangle in Fig. 3. These results offer insights on the CQD solar cell homogeneity, and on effects of the Au contact associated interface states on carrier transport dynamics. As tabulated in Table 1, other parameters involved in Eq. (14) were taken from the literature or measured experimentally. The lifetime image in Fig. 5(a) reveals lower $\tau$ values (0.35 μs–0.55 μs) for regions with than those without Au contacts, which can be attributed to the presence of enhanced trap state densities at Au/PbS-EDT interfaces. These trap states act as nonradiative recombination centers, dissipating energy, therefore, diminishing the overall carrier lifetime. These trap state enhancements at the metal/CQD interfaces can be reduced, first through improving the quality of the quantum dots themselves; second, through minimizing the effects of electrode contacts and the metal deposition processes. The CQD quality can be enhanced through surface materials chemistry [32,33] and improved synthesis methodologies [34,35]. For example, surface-passivation ligands with less mismatch to the dot lattice can be chosen [36], and solution-processed ligand exchange rather than solid-state exchange [1] can be applied and tested for CQD synthesis. Furthermore, although Au deposition was conducted at room temperature through thermal evaporation, using HeLIC imaging we found that in electrode contact-free regions the carrier lifetime also decreases after the thermal evaporation process for Au contact deposition. This is probably due to the surface damage incurred by the observed locally increased temperature and increased atomic collisions during the thermal evaporation process. Therefore, further investigation of the effects of the Au deposition process on CQD quality is recommended in a search for more robust CQD surface-passivation ligands that can endure local high temperature and atomic collisions during the contact deposition process.

In the framework of carrier hopping transport within CQD-based materials and devices, when energy disorder does not exceed the room temperature thermal energy $kT$, the character of carrier diffusion in CQD thin films can be treated as random which validates the mobility $\mu_e$ approximation using a three-dimensional random walk theory [37], i.e.

$$\mu_e = \frac{eL_{\text{diff}}}{kTn_{\text{hop}} \tau}$$

(16)

where $n_{\text{hop}}$ is the average total number of the interdot hopping events an electron experiences before recombining radiatively or non-radiatively. Eq. (16) shows that $\mu_e$ increases with decreasing $\tau$. Considering the hopping Einstein relation [2]

$$D_e = \frac{\mu_e kT}{\exp\left(\frac{E_a}{kT}\right)}$$

(17)

in which $E_a$ is the hopping activation energy, it can be seen that $D_e$ also increases with decreasing $\tau$, a fact mirrored in the diffusivity image of Fig. 5(b) which shows that the Au region possesses higher $D_e$. As for charge carriers, Eq. (16) predicts an electron diffusion length on the order of $10^2$ nm that demonstrates the validity of diffusion length $L_{\text{diff}}$ values in the image of Fig. 5(c) with higher $L_{\text{diff}}$ in the Au regions. Although $\tau$ is lower in the Au regions, $\mu_e$ is expected to be higher using the random walk model, therefore, a tradeoff between lifetime and mobility.
be noted that circular tip of a single solar cell electrode as shown in Fig. 3. PCR image construction and measurements. However, as further elaborated below, the “knee” frequency in Fig. 6, at which the PCR (same for HeLIC imaging) amplitudes start to decrease drastically, bears direct relationship to the carrier lifetime and other parameters which the PCR (same for HeLIC imaging) amplitudes start to decrease drastically, bears direct relationship to the carrier lifetime and other carrier transport parameters. The dynamic nature of the LIC and PCR techniques where quantitative information is extracted from the frequency response of the signals rules out any effects of Au-related reflection fluctuations across the surface on carrier transport parameter image construction and measurements.

PCR based on a single detector can be used for single spot measurements with a laser beam diameter of 3 mm which is the area of the circular tip of a single solar cell electrode as shown in Fig. 3. PCR amplitude and phase frequency scans on solar cell A in Fig. 3 are shown in Fig. 6(a) and (b), respectively. They resemble the HeLIC amplitude signal dependence on modulation frequency. As shown in Fig. 6(a), due to the reduced carrier-phonon interactions at low temperatures and a concomitant increase in the radiative emission rate accomplished by a decrease in the nonradiative decay rate, the PCR amplitude increases greatly at low temperatures. Correspondingly, higher carrier lifetimes at low temperatures yield an increased PCR phase lag compared to that at higher temperatures. The “knee” of a typical PCR amplitude and phase occurs at a frequency \( f \sim 1/2\pi \tau \), reflecting a direct estimate of carrier lifetime. The best-fitted carrier lifetimes using Eq. (12) at different temperatures for solar cells A and B, as well as in the region C without Au electrode contact shown in Fig. 3, are tabulated in Table 2. It is observed that carrier hopping lifetimes increase with decreasing temperature, indicating the phonon-assisted carrier hopping transport behavior of CQD-based materials and devices [2,6,25,27,38]. Carrier lifetime characterization using PCR further demonstrates that contact with the Au electrode diminishes the carrier hopping lifetime. For region C without Au contact, lifetimes significantly increase at low temperatures of 200 K and 100 K to 8.05 and 26.35 \( \mu \)s, respectively. Our J-V characteristics yield PCEs of solar cell B (8.4%) lower than that of A (9.0%), which is consistent with the lower lifetime of solar cell B when compared with A at all temperatures.

As a result, the PCR, HoLIC, and, especially, HeLIC technique can be very useful in solar cell manufacturing. For example, HeLIC can conduct fast, nondestructive, and contactless monitoring of in-line solar cell substrate and device homogeneity, providing qualitative information about product quality and entire image contrast dominated by the carrier lifetime distribution across the surface. Through more detailed analysis of multi-frequency image sets, large-area quantitative imaging of solar cell transport parameters associated with photovoltaic electrical properties can be reconstructed for more specific quality control of solar-cell products. Such photovoltaic parameter images are useful for further solar-cell efficiency optimization from materials screening to device processing and manufacturing method optimization in industry.

5. Conclusions

Fundamental carrier transport parameters and their distribution in CQD solar cells have been investigated for device PCE optimization purposes using HoLIC, HeLIC, and PCR as emerging dynamic quantitative interface non-destructive imaging methodologies, showing great potential for fundamental photovoltaic optoelectronic transport studies and industrial in-line or off-line manufactured large-area solar cell device characterization. Specifically, it was demonstrated that, compared with regions without Au contact, enhanced trap state density at the Au/CQD interface results in shorter electron carrier lifetime (ca. 0.5 \( \mu \)s), and higher diffusivity (ca. \( 4 \times 10^{-5} \) cm/s), parameters that yield longer diffusion and drift lengths within the framework of a random walk hopping transport model.

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